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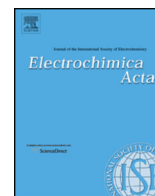
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Tuning inner-layer oxygen functional groups of reduced graphene oxide by potentiostatic oxidation for high performance electrochemical energy storage devices



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ABSTRACT

The electrochemical lithiation/delithiation of oxygen-containing functional groups (OCFGs) of nano-carbon materials, particularly graphene, have attracted intensive interest in recent years. Here, we propose a controllable potentiostatic oxidation approach to tune the OCFGs of as-prepared reduced graphene oxide (rGO) in a carbonate-based electrolyte to improve the specific capacity and rate capability. By X-Ray absorption spectroscopy in total fluorescence yield mode and X-Ray diffraction, we confirm that potentiostatic oxidations generate new OCFGs in the inner-layer of rGO. The content of OCFGs increases as oxidation potential being elevated. Such increasing of OCFGs in quantity significantly enhances the capacity. For instance, the specific capacity of 170.4 mAh g^{-1} for pristine rGO electrode is increased to 290.5 mAh g^{-1} after the oxidation at 5.0 V. We demonstrate that oxidations at moderate potentials can reduce the electrochemical and ohmic polarizations of rGO electrodes without deteriorating diffusion dynamic, thereby improving rate capability. After the optimal oxidation at 4.7 V, rGO electrode exhibits an excellent rate capability, delivering 58.4 mAh g^{-1} at 20 A g^{-1} .

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1. Introduction

Carbon materials play a crucial role in electrochemical energy storage devices. The electrochemical lithiation/delithiation of oxygen-containing functional groups (OCFGs), i.e. C–O–C, >C=O and COOH, of carbon nanotube (CNT) [1–6], graphene [7–19], CNT/graphene hybrid [20,21] and CNT/carbon sphere hybrid [22] in 1.5 ~ 4.5 V (vs Li/Li⁺) have been attracted intensive interest in recent years. The involved faradic processes contribute to additional charge storage, thus enhancing the energy density of these nanocarbon materials. A pioneering study by Lee et al. demonstrated the lithiation/delithiation redox reactions of OCFGs on CNTs in a carbonate-based electrolyte improve the capacity significantly [1]. Jang et al. figured out that these redox reactions are present in reduced graphene oxide (rGO) as well [7]. Taking advantage of pseudocapacitive behavior in a wide potential range for the lithiation/delithiation of the OCFGs, and the unique features of graphene including 2D geometry, controllable surface chemical

structure, exceptional mechanical and electric properties, eco-friendly cells with graphene as both cathode and anode materials, named all-graphene-batteries [7,13] or all-graphene-lithium ion supercapacitors [12,18], have been explored. An all-graphene-cell delivers an energy density of 225 Wh kg^{-1} [13], 40 times higher than that of conventional supercapacitors.

It is reported that more OCFGs could contribute to higher capacity [11,20]. Excessive OCFGs, however, may severely interrupt the π conjugation, which is vital for the in-plane electronic transport through delocalized electrons. If the pursuit of OCFGs enrichment is overdone, the lowered electronic conductivity will eventually deteriorate the electrochemical performance. Therefore, it is necessary to optimize the number of OCFGs to address the tradeoff between more active OCFGs and higher electronic conductivity. To achieve the rGO electrode with wonderful electrochemical properties, such as specific capacity and rate capability, the chemical engineering on its OCFGs is imperative. Approaches by adjusting oxidizing agent amount in the stage of preparing graphene oxide (GO) [11], or changing thermal reduction temperatures [10,15], electrochemical reduction potentials [23] and hydrothermal reduction duration [14], realize controlling the content of oxygen in rGO. In general, these approaches are confined

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in the period of rGO fabrication. To broaden the way to tune the OCFGs of rGO precisely, a new strategy through a post-modification on rGO is worth of attention.

The precursor of rGO, namely GO, is fabricated by wet-chemistry processes involving harsh oxidation. Graphene sheets are prone to restacking into multi-layer structure due to the strong π - π interaction among them. As from the reduction of GO, rGO contains OCFG residual both on the outmost surface and in the inner layers of the restacked multi-layer architecture. OCFGs in the inner layers can take part in electrochemical lithiation/delithiation reactions through lithium ion diffusion, which will even become the main way to store charge when the layer number is large. Therefore, it is greatly desired that the new post-modification approach has the capability to tune the OCFGs not only on the surface, but also in the inner layers of rGO.

Herein, we develop a controllable potentiostatic oxidation approach to tune the content of OCFGs for as-prepared rGO. X-Ray absorption spectroscopy in bulk-sensitive total fluorescence yield mode (TFY-XAS), X-Ray diffraction (XRD) and Raman spectroscopy were employed to characterize the modified rGO electrodes aimed at confirming a bulk-tuning for OCFGs. We demonstrated that this approach enhances the specific capacity of rGO electrode. In addition, the rate capability could also be significantly improved by optimizing the oxidation potential.

2. Experimental

2.1. Electrode preparation and cell assembly

The rGO powder (supplied by Advanced Carbons Division of Shenyang National Laboratory for Materials Science) used in this study was produced from graphite oxide via a common thermal reduction route. Fig. S1 shows scanning electron microscopy (SEM) and transmission electron microscopy (TEM) images, nitrogen adsorption/desorption isotherms and X-Ray photoelectron spectroscopy (XPS) spectrum of the rGO powder. The Brunauer-Emmett-Teller specific surface area of rGO is $334 \text{ m}^2 \text{ g}^{-1}$, indicating its 8-layer structure in average. Its carbon/oxygen atomic ratio is 9.5:1. To prepare rGO electrodes, a slurry was first prepared by mixing 70 wt% of rGO powder with 20 wt% conductive carbon black (Super P) and 10 wt% Poly (vinylidene fluoride) (PVDF) dissolved in N-methyl-2-pyrrolidone (NMP). The slurry was further diluted by

NMP to a moderate viscosity, then magnetically stirred for more than 12 hours and casted onto an Al foil via a tape casting process. After drying at 50°C in an oven for 6 hours, the rGO-coated Al foil was punched to obtain plates with diameter of 15.5 mm. Then these plates were pressed under 60 MPa and dried in vacuum at 120°C for 12 hours to obtain rGO electrodes. The loading mass of rGO in electrodes ($\sim 0.15 \text{ mg}$) are listed in Table S1.

In an argon filled glove box with oxygen and water less than 1 ppm (MBRAUN, Germany), an rGO electrode and a Li metal foil separated by Celgard M824 membrane were assembled into a CR-2032 type coin cell. 1 M LiPF_6 in ethylene carbonate (EC)/dimethyl carbonate (DMC) (1:1 vol) solution was used as the electrolyte.

2.2. Potentiostatic oxidation and electrochemical measurements

The rGO/Li CR-2032 coin cells were adopted to perform potentiostatic oxidations as illustrated in Fig. 1. After galvanostatic charging at 50 mA g^{-1} to high potentials ranging from 4.6 to 5.0 V, oxidizations for 10 h were carried out. rGO electrodes were labeled according to oxidation potentials and time.

The specific capacities of graphene electrodes were evaluated by galvanostatic charge-discharge measurements. Charge-discharge cycles were conducted between 1.5 to 4.5 V (vs Li/Li^+). A galvanostatic battery tester (LANHE CT2001A, China) and an electrochemical workstation (Autolab 302N, Netherland) with a faster data acquisition rate of 780 samples per second were used for measuring capacities at low and high current densities, respectively. The values of current densities and capacities in this paper is based on the mass of graphene in electrodes.

Galvanostatic intermittent titration (GITT) measurements for pristine and oxidized rGO electrodes after 10 charging/discharging cycles were carried out with the LANHE CT2001A. A constant current pulse of 50 mA g^{-1} was applied for 10 minutes, followed by an open-circuit relaxation period of 2 h. Potentials at end of each open-circuit relaxation were recorded to calculate dE/dx , the slope of GITT curve at each capacity (x) value.

Electrochemical impedance spectroscopy (EIS) measurements at various potentials for pristine and oxidized rGO electrodes after 10 charging/discharging cycles were performed with frequency response analyzer (Autolab FRA32 module embedded in Autolab 302N). The frequency range was from 10 mHz to 1 MHz with an ac signal amplitude of 10 mV. Impedance spectra were analyzed using

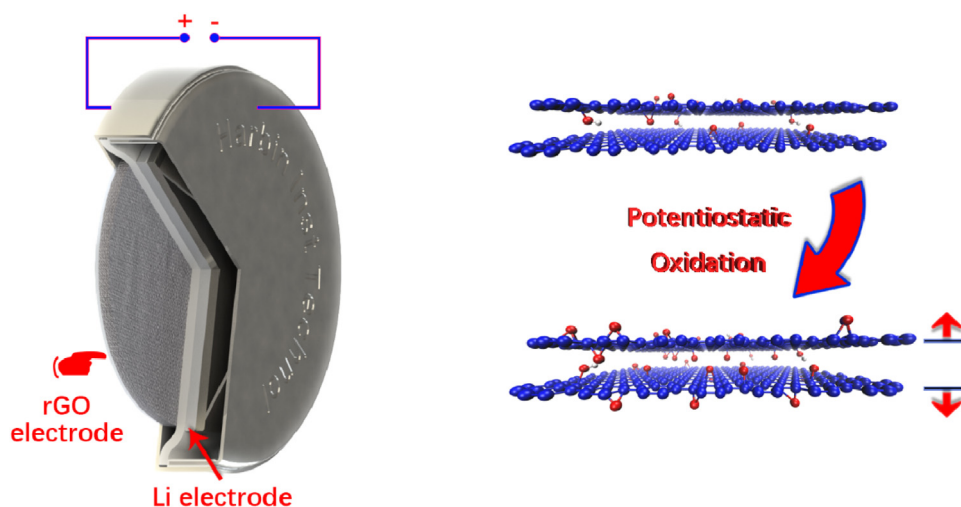


Fig. 1. Schematic illustration of the potentiostatic oxidation process, and the chemical and structural change of rGO (only bi-layer structure is drawn for simplification). Blue and red ball stand for C and O atoms, respectively.

NOVA software to obtain charge transfer resistance (R_{CT}) and solid-electrolyte interphase (SEI) resistance (R_{SEI}). In addition, the lithium ion diffusion coefficients were measured by EIS method, specifically calculated by following equation [24,25]:

$$D = \frac{1}{2} \left[\frac{V_m}{FA\sigma} \left(-\frac{dE}{dx} \right) \right]^2$$

where D is diffusion coefficient of ion, A is apparent area of electrode, σ is Warburg coefficient, V_m is molar volume of active material, F stands for the Faraday constant (96480 C mol^{-1}). Here, A is 1.886 cm^2 . V_m value for each rGO is calculated by $V_m = (d(002)/0.336 \text{ nm}) \times 5.31 \text{ cm}^3 \text{ mol}^{-1}$, in which $d(002)$ is interlayer spacing of rGO measured by XRD, 0.336 nm and $5.31 \text{ cm}^3 \text{ mol}^{-1}$ are the interlayer spacing and molar volume of graphite with a density of 2.26 g cm^{-3} , respectively. Warburg coefficient is calculated from real part of impedance, Z' , by linear fitting on $Z' - \omega^{-1/2}$ plot, where ω is angle frequency.

2.3. Structure and Chemistry Characterizations

After potentiostatic oxidations, cells were disassembled to preform characterizations of rGO electrodes. The interlayer spacing of rGO was measured by an X-Ray diffractometer (Bruker D8 advance, German) using $\text{Cu K}\alpha$ radiation with 0.04° interval step. A confocal microscope Raman spectrometer system (BWTEK BWS435-532SY, America) with 532 nm excitation wavelength was used to record Raman spectra. The laser power was as low as 50 mW .

Carbon K-edge XAS of pristine and oxidized rGOs were acquired at BL8.0.1 in the Advanced Light Source, Lawrence Berkeley National Laboratory. In order to eliminate interference from carbon species in PVDF binder, binder-free rGO electrodes were prepared by tightly compacting rGO powder with stainless steel grids

(400 mesh). Two binder-free rGO electrodes were oxidized at 4.7 and 5.0 V , respectively, for 10 h in CR-2032 coin cells before the XAS measurement. One pristine rGO electrode (charged to 4.5 V , denoted as pris-4.5V) in fully-delithiated state was also prepared as control sample.

3. Results and discussion

3.1. Characterization of potentiostatically oxidized rGO electrodes

After potentiostatic oxidations at different potentials, the content of OCFGs increases and the interlayer spacing gets to be enlarged as illustrated in Fig. 1. Details on the chemical and structural changes by the oxidations are described and discussed below.

TFY-XAS is a powerful technique to probe the unoccupied states of molecules. In comparison with extremely surface-sensitive XPS, TFY-XAS has the advantage of larger detection depth of approximate one hundred nanometers, thereby minimizing the interference from C species in the solid-electrolyte interphase (SEI) layer on electrode surface. To investigate the variation trend of each OCFG in rGO after potentiostatic oxidations at different potentials, the carbon K-edge XAS of representative electrodes including pris-4.5V, 4.7V_10h and 5.0V_10h are analyzed in Fig. 2. Peak B at 285.2 eV corresponds to the transition of C 1s to π^* orbitals in C=C bond, a typical signature of the sp^2 hybridized carbon materials. Peak I at 292.5 eV arises from the $1s$ -to- σ^* transition in π -conjugated carbon materials. It is worthwhile to mention that the peak H at 291.8 eV is the core-excitation [26,27] and its presence indicates that there is still large sp^2 network domain in rGO sheets after potentiostatic oxidations. Originating from the interruption of sp^2 network domain by OCFGs, the defect-induced peak A at 283.7 eV [28,29] is identified after the deconvolution. The

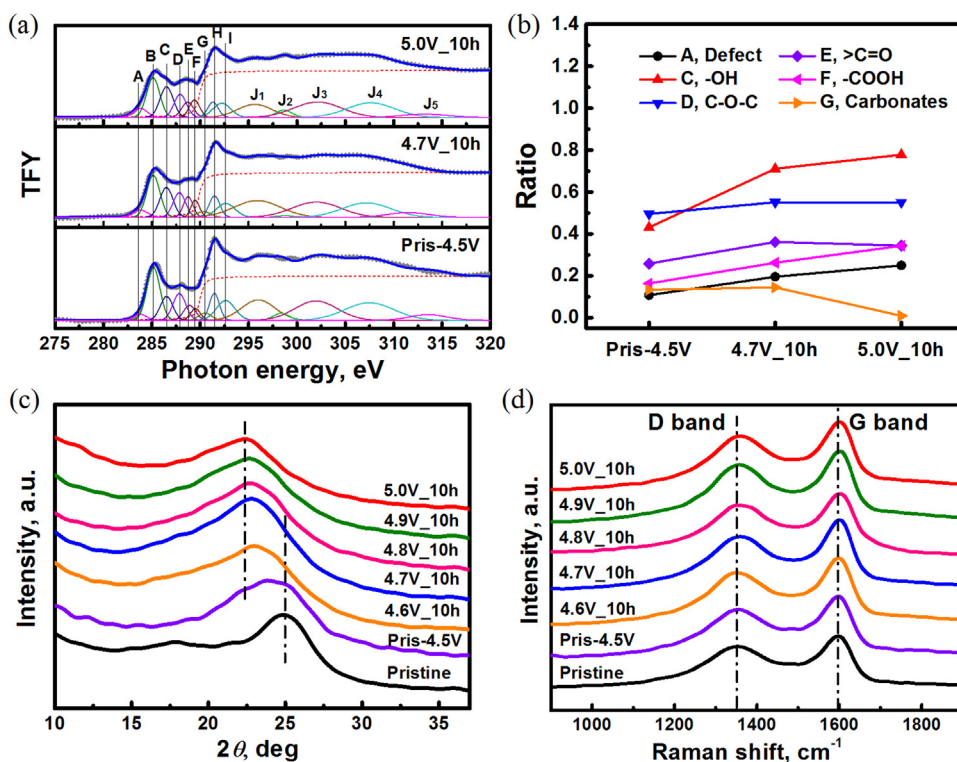


Fig. 2. (a) C K-edge XAS spectra of pristine rGO, 4.7V_10h and 5.0V_10h electrodes, (b) area ratios of OCFG peaks with C π^* resonance peak for the pristine and oxidized rGOs. (c) XRD patterns and (d) Raman spectra of pristine and oxidized rGOs.

C, D, E and F peaks at 286.5, 287.8, 288.7 and 289.7 eV are from C 1s to π^* resonances of C—OH, C—O—C, >C=O and COOH, respectively [30,31]. Besides, the peak G at 290.3 eV is attributed to carbonates, such as Li_2CO_3 and ROCOOR [32–34], in SEI layers formed on rGO electrodes. J_1 – J_5 peaks from C 1s to σ^* resonances of OCFGs bonds are also present in higher photon energy region [35].

The area ratios of A, C, D, E, F and G peaks with respect to B peak, quasi-quantitatively proportional to the relative concentration of each species in rGO electrodes, are plotted in Fig. 2(b). Except a maximum of >C=O is obtained for 4.7V_10h electrode, the total concentration of OCFGs (i.e. C—OH, C—O—C, >C=O and COOH) is favorable to be increased with elevating the oxidation potential. The increase of defect (peak A) indicates the break of C_6 rings providing the reaction sites for oxygen interaction. This result suggests that potentiostatic oxidation is able to facilitate the generation of new OCFGs in carbonate-based electrolytes. It has been reported that the sp^2 conjugative carbon structures of graphite or graphene sheets can be destructed and transformed into OCFGs under high oxidation potentials in aqueous solutions [30,36,37] or ionic liquids [38,39]. But electrochemical oxidations in carbonate-based electrolytes are still rarely reported. We expect such potentiostatic oxidation approach to be a controllable way for improving the pseudocapacitive performance of rGO electrode.

XRD patterns in Fig. 2(c) shows a shift of (002) peak from 25.00° towards 22.29° as oxidation potential increasing to 5.0V, corresponding to an enlargement of interlayer spacing from 3.56 Å to 3.99 Å. Fig. 2(d) indicates that there is no significant change for G band in Raman spectra. Although the intercalation of anions at high potentials is readily to enlarge the interlayer spacing

[40,41], such intercalation could be excluded due to the absence of the essential splitting of Raman G band for graphite intercalated compounds [42–44]. We attribute this interlayer spacing enlargement to the enhanced repulsion among polar OCFGs in the interior of the rGO rather than the intercalation of PF_6^- . The enlargement of interlayer spacing confirms that tuning inner-layer OCFGs in rGO is achieved by our potentiostatic oxidation approach.

3.2. Effect of oxidation potentials on the electrochemical performance

OCFGs (i.e. C—O—C [9], >C=O [7] and COOH [1,2,20]) have been shown to be electrochemically active in the carbonate-based electrolyte between 1.5 ~ 4.5 V, while C—OH might be less active as its lithiation potential as low as 0.585 V predicted by a first-principle calculation [45]. Fig. 3(a) shows galvanostatic charge-discharge curves (at 50 mA g^{-1}) with varied slopes against potentials, indicating that the charging-discharging of all electrodes involves pseudocapacitive reactions from active OCFGs. The specific capacity increases from 177.5 mAh g^{-1} to 290.5 mAh g^{-1} as oxidation potentials rise from 4.6 V to 5.0 V, higher than 170.4 mAh g^{-1} for pristine rGO electrode. Potentiostatic oxidations successfully induced more electrochemically active OCFGs into rGO electrodes as pseudocapacitive reaction sites in the carbonate-based electrolyte.

These oxidized rGO electrodes exhibit good cycle performance as shown in Fig. 3(b). During the long-time operation, pristine and 4.6 ~ 4.8 V oxidized electrodes even show a self-enhanced cycle performance, which is likely due to the gradual penetration of electrolyte into more inner pores of electrodes as described in

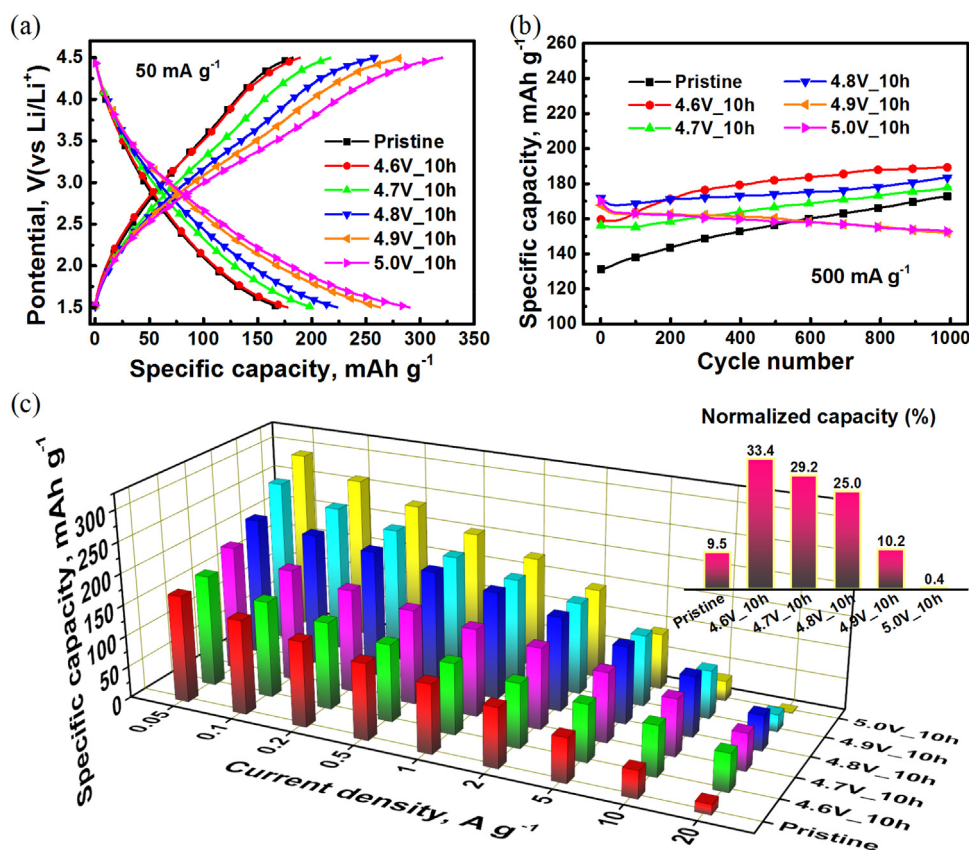


Fig. 3. Electrochemical performance of pristine and oxidized rGO electrodes. (a) charge-discharge curves under a current density of 50 mA g^{-1} , (b) cycle performance of pristine and oxidized rGO electrodes at 0.5 A g^{-1} , (c) discharge specific capacities at the current densities from 50 mA g^{-1} to 20 A g^{-1} . The insert in (c) is normalized capacities at 20 A g^{-1} with respect to those at 50 mA g^{-1} for each electrode.

several published literatures [11,13–16]. In contrast, the 4.9 and 5.0V oxidized electrodes suffer a slight fading because of the lack of a stable SEI layer [17].

The rate performance of these oxidized rGO electrodes is shown in Fig. 3(c). When the current density is set below 2 A g^{-1} , the specific capacity shows an upward tendency as oxidation potentials increasing. Whereas under the higher current density, the rGO electrodes oxidized at moderate potentials deliver higher capacities than others. The insert in Fig. 3(c) shows the normalized capacities at 20 A g^{-1} by those at 50 mA g^{-1} . In comparison with pristine rGO electrode, moderately oxidized electrodes (4.6V_10h, 4.7V_10h and 4.8V_10h electrodes) offer higher normalized capacities (33.4%, 29.2% and 25.0%, respectively) than other three electrodes. The 4.9V_10h electrode has a normalized capacity close to pristine electrode at 20 A g^{-1} , while this capacity falls to only 0.4% for 5.0V_10h. If considering real application, we expect the 4.7V_10h electrode (58.4 mAh g^{-1} at 20 A g^{-1}) to be used in an electrochemical energy storage device with high power performance, and 5.0V_10h electrode (290.5 mAh g^{-1} at 50 mA g^{-1}) to be used under the demand of high energy density.

3.3. Effect of oxidation potentials on polarization and diffusion dynamic

To understand the effect of potentiostatic oxidation on rate performance, impedance and diffusion coefficient measurements were performed. These measurements were restricted within two potential ranges, 2.7~1.8V in cathodic process and 3.2~4.2V in anodic process to ensure the electrodes being in faradic reaction-

dominated potential region under the concern of their poor reversibility [1–4,7]. After fitting the impedance spectra (Fig. S2) of the representative pristine rGO, 4.7V_10h and 5.0V_10h electrodes (an example fitted by our equivalent circuit model is shown Fig. S3), we obtain the potential dependent resistances of charge transfer (R_{CT}) and solid-electrolyte interphase (R_{SEI}) as illustrated in Fig. 4. Under all potentials applied, pristine rGO electrode exhibits the highest R_{CT} and lowest R_{SEI} , while 4.7V_10h electrode shows the lowest R_{CT} and highest R_{SEI} . It is noteworthy that the averaged sum of R_{CT} and R_{SEI} (R_{CT+SEI}) increases in the order of 4.7V_10h (336.2 Ohm), pristine (346.5 Ohm), 5.0V_10h (387.6 Ohm). This result implies that moderate oxidations around 4.7V can reduce the electrochemical polarization, but excessive oxidations above 4.9V will deteriorate the electrochemical dynamic.

To investigate the ohmic polarization, IR drop was measured from galvanostatic charge-discharge curves (see Fig. S4 for the details of IR drop measurement). The linear dependence of IR drops on current densities is shown in Fig. 4(a) and these points were fitted by least-square linear method to give out the slopes (Fig. 4(b)). The slopes are determined by the electronic resistances of electrodes plus ionic resistance of electrolyte [46,47]. Fig. 4(b) indicates that the resistance of rGO electrode decreases dramatically after the 4.6V oxidation, then increases monotonously with enhancing potentials. The resistance decrease by 4.6V oxidation is a result of the improved wettability of electrode in the electrolyte by potentialstatic oxidations. While the resistance increase by 5.0V oxidation is due to the excessive disruption of π conjugated network in rGO sheets.

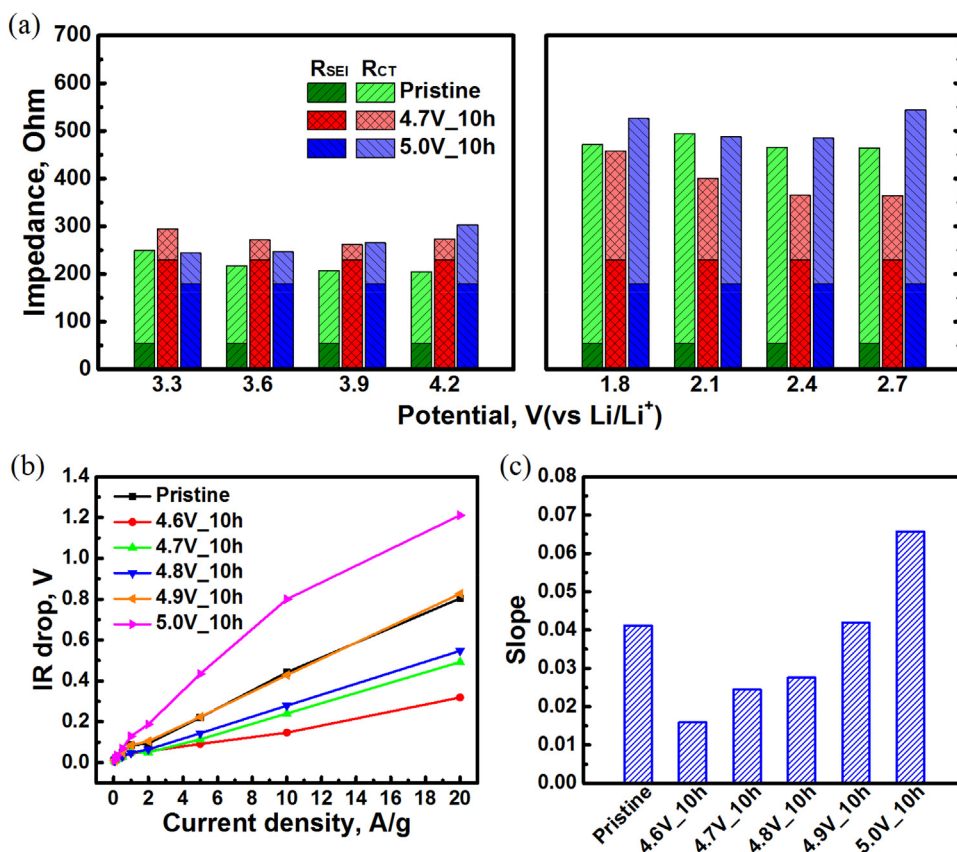


Fig. 4. (a) Potential-dependent R_{CT} and R_{SEI} of pristine rGO, 4.7V_10h and 5.0V_10h electrodes in faradic reaction-dominated potential region. Left and right panels are recorded in anodic and cathodic polarization processes, respectively. (b) Dependence of IR drops on current densities, (c) slopes of IR drops vs current densities for pristine rGO and oxidized rGO.

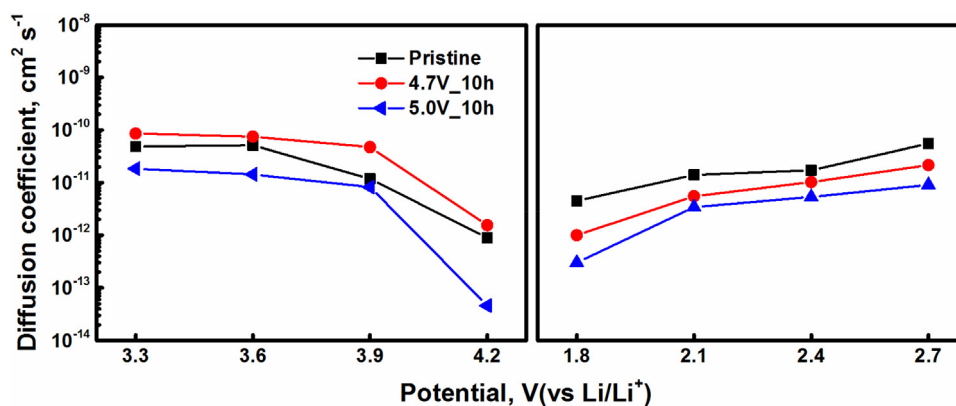


Fig. 5. Potential-dependent lithium ion diffusion coefficients of pristine rGO, 4.7V_10h and 5.0V_10 electrodes in anodic (from 3.3 to 4.2 V) and cathodic (from 2.7 to 1.8 V) reaction-dominated potential regions.

Fig. 5 shows the lithium ion diffusion coefficients at various potentials, calculated by impedance spectra (Fig. S2) combining with GITT curves (Fig. S5). The averaged diffusion coefficient of 4.7V_10 h electrode ($2.3 \times 10^{-11} \text{ cm}^2 \text{ s}^{-1}$) is slightly higher than that of pristine electrode ($2.1 \times 10^{-11} \text{ cm}^2 \text{ s}^{-1}$), while 5.0V_10 h electrode has a lower value ($5.3 \times 10^{-12} \text{ cm}^2 \text{ s}^{-1}$). This result reveals that the transport of lithium ion in graphene sheets will be hindered by the excessive OCFGs because the interaction of lithium ion with OCFGs elevates the energy barrier for lithium ion bulk diffusion [48–50]. The slight increase for 4.7V_10 h electrode can be interpreted by considering that the enlarged interlayer spacing benefits bulk diffusion.

The measured impedance values and diffusion coefficients of the three representative electrodes indicate that the potentiostatic oxidations under moderate potentials minimizes the electrochemical and ohmic polarizations of rGO electrode without retarding diffusion dynamic, thereby enhancing rate performance. In combination with the high specific capacity induced by newly formed OCFGs, our potentiostatic oxidation approach is demonstrated to be effective for improving the pseudocapacitive performance of graphene electrode.

4. Conclusions

Tuning the OCFGs of rGO has been achieved by potentiostatic oxidations in an EC/DMC carbonate-based electrolyte. Taking advantage of good bulk-sensitivity of TFXAS and XRD, we confirm that potentiostatic oxidations generate new electrochemically active OCFGs (i.e. C–O–C, >C=O and COOH) not only on outmost surface but also in the inner-layers of graphene sheets. This increasing of OCFGs in quantity contributes to the enhanced pseudocapacitive capacity. For instance, the specific capacity of 170.4 mAh g^{-1} for pristine electrode is increased to 290.5 mAh g^{-1} after 5.0V oxidation. Moreover, the potentiostatic oxidations at moderate potentials around 4.7V can reduce the electrochemical and ohmic polarization, and makes the oxidized electrodes inherit the good diffusion dynamic, thereby improving the rate capability.

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Appendix A. Supplementary data

Supplementary data associated with this article can be found, in the online version, at <http://dx.doi.org/10.1016/j.electacta.2017.03.223>.

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